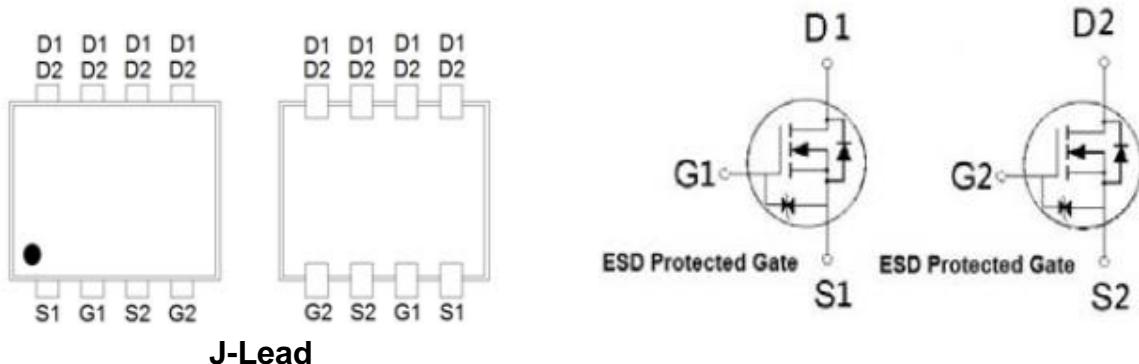


PJ614DA

Dual N-Channel Enhancement Mode MOSFET

PRODUCT SUMMARY

$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
20V	12.5mΩ @ $V_{GS} = 4.5V$	9A



ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ C$ Unless Otherwise Noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNITS
Drain-Source Voltage		V_{DS}	20	V
Gate-Source Voltage		V_{GS}	± 10	
Continuous Drain Current ²	$T_A = 25^\circ C$	I_D	9	A
	$T_A = 70^\circ C$		7	
Pulsed Drain Current ¹		I_{DM}	28	A
Avalanche Current		I_{AS}	22	
Avalanche Energy	$L=0.1mH$	E_{AS}	24	mJ
Power Dissipation	$T_A = 25^\circ C$	P_D	1.7	W
	$T_A = 70^\circ C$		1	
Operating Junction & Storage Temperature Range		T_j, T_{stg}	-55 to 150	°C

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient	$R_{\theta JA}$		73	°C / W

¹Pulse width limited by maximum junction temperature.

²Package limitation current is 7A.

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ELECTRICAL CHARACTERISTICS ($T_J = 25^\circ\text{C}$, Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNITS
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	20			V
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$	0.35	0.7	1	
Gate-Body Leakage	I_{GSS}	$V_{\text{DS}} = 0\text{V}, V_{\text{GS}} = \pm 8\text{V}$			± 30	
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}} = 16\text{V}, V_{\text{GS}} = 0\text{V}$			1	μA
		$V_{\text{DS}} = 10\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 70^\circ\text{C}$			10	
Drain-Source On-State Resistance ¹	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}} = 1.8\text{V}, I_D = 3\text{A}$	13.6	15.1	20.2	$\text{m}\Omega$
		$V_{\text{GS}} = 2.5\text{V}, I_D = 3\text{A}$	10.4	11.9	15	
		$V_{\text{GS}} = 3.9\text{V}, I_D = 3\text{A}$	9	10.5	13.7	
		$V_{\text{GS}} = 4.5\text{V}, I_D = 3\text{A}$	8.7	10.2	12.5	
Forward Transconductance ¹	g_{fs}	$V_{\text{DS}} = 5\text{V}, I_D = 3\text{A}$		40		S
DYNAMIC						
Input Capacitance	C_{iss}	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 10\text{V}, f = 1\text{MHz}$		1133		pF
Output Capacitance	C_{oss}			214		
Reverse Transfer Capacitance	C_{rss}			168		
Gate Resistance	R_g	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 0\text{V}, f = 1\text{MHz}$		1.5		Ω
Total Gate Charge ²	Q_g	$V_{\text{DS}} = 10\text{V}, V_{\text{GS}} = 4.5\text{V}, I_D = 3\text{A}$		17.4		nC
Gate-Source Charge ²	Q_{gs}			1.1		
Gate-Drain Charge ²	Q_{gd}			5.1		
Turn-On Delay Time ²	$t_{\text{d}(\text{on})}$	$V_{\text{DS}} = 10\text{V}, I_D \approx 3\text{A}, V_{\text{GS}} = 4.5\text{V}, R_G = 6\Omega$		24		nS
Rise Time ²	t_r			32		
Turn-Off Delay Time ²	$t_{\text{d}(\text{off})}$			66		
Fall Time ²	t_f			35		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS						
Continuous Current	I_S				1.4	A
Forward Voltage ¹	V_{SD}	$I_F = 3\text{A}, V_{\text{GS}} = 0\text{V}$			1.2	V
Reverse Recovery Time	t_{rr}	$I_F = 3\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		14		nS
Reverse Recovery Charge	Q_{rr}			5.4		nC

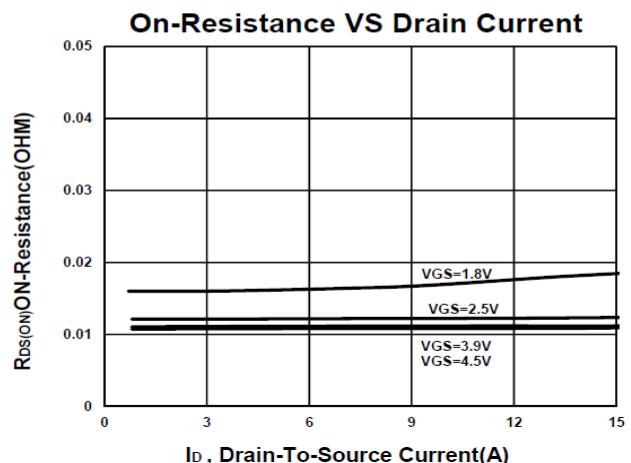
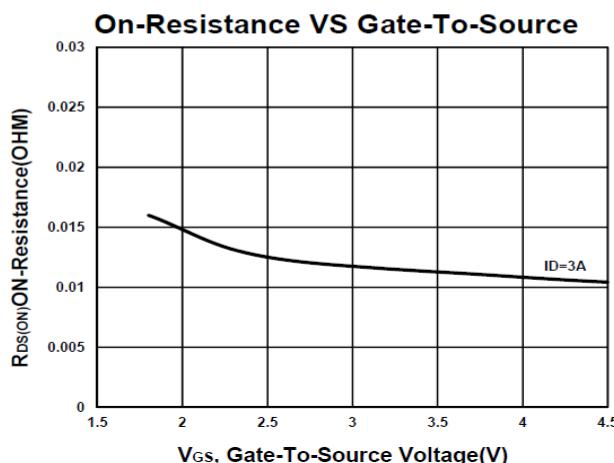
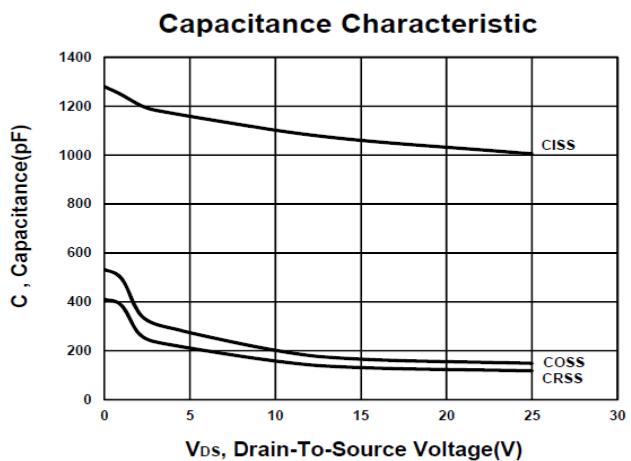
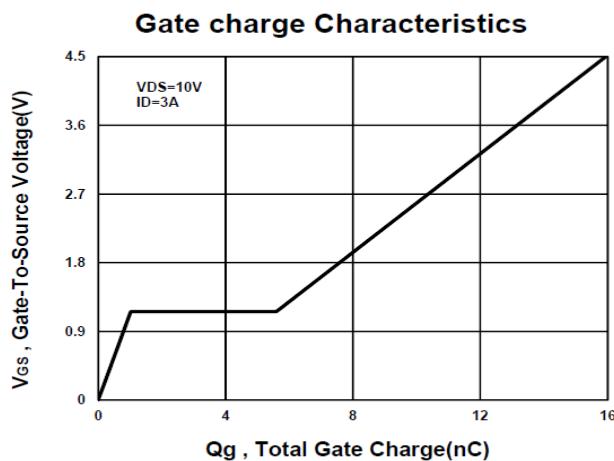
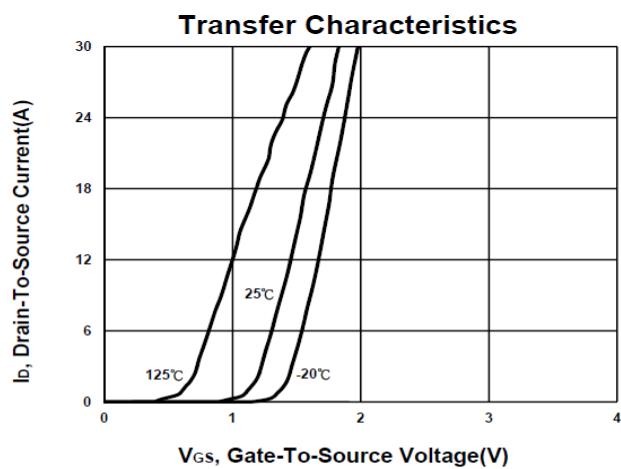
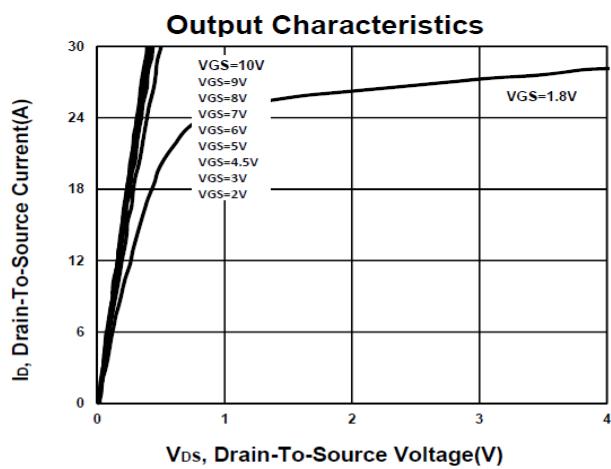
¹Pulse test : Pulse Width $\leq 300\text{ }\mu\text{sec}$, Duty Cycle $\leq 2\%$.

²Independent of operating temperature.

³Pulse width limited by maximum junction temperature.

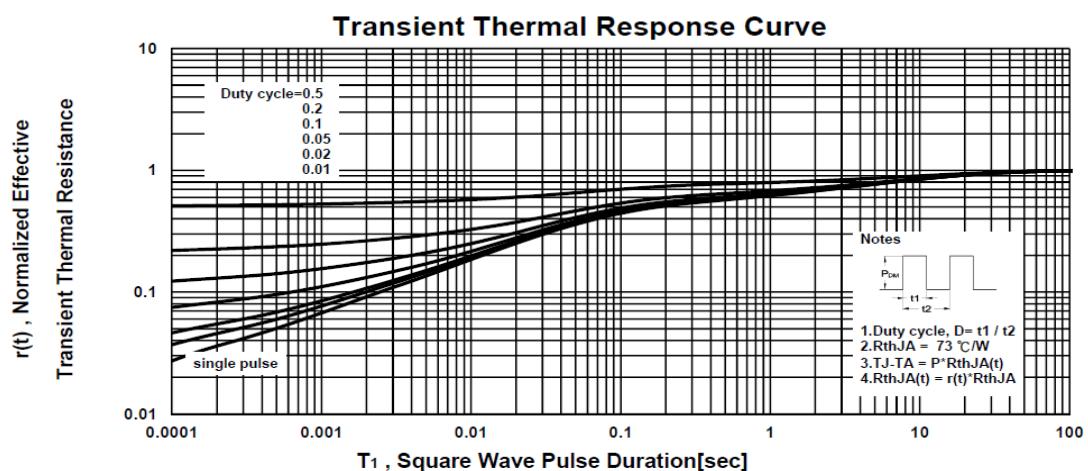
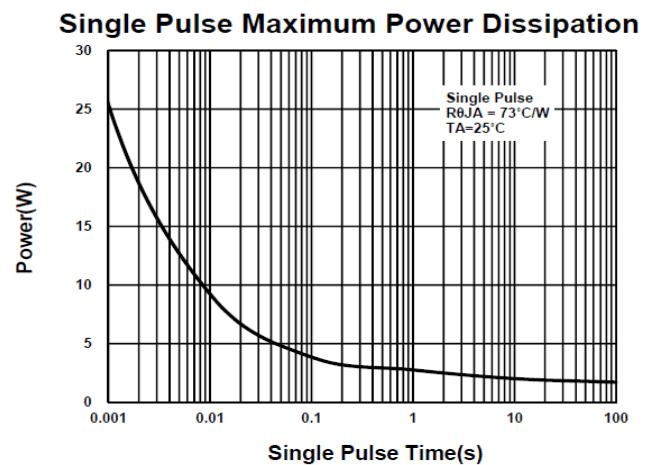
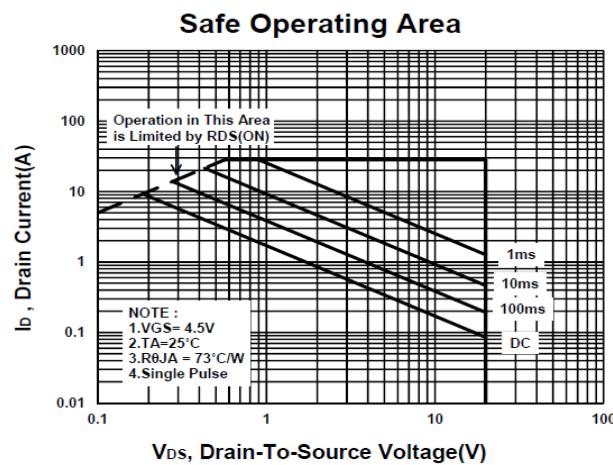
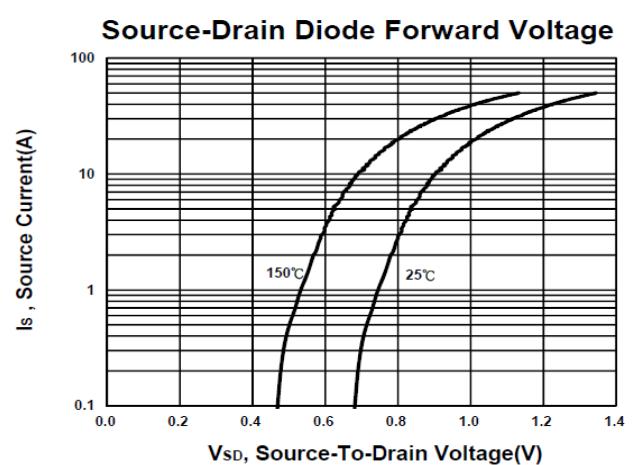
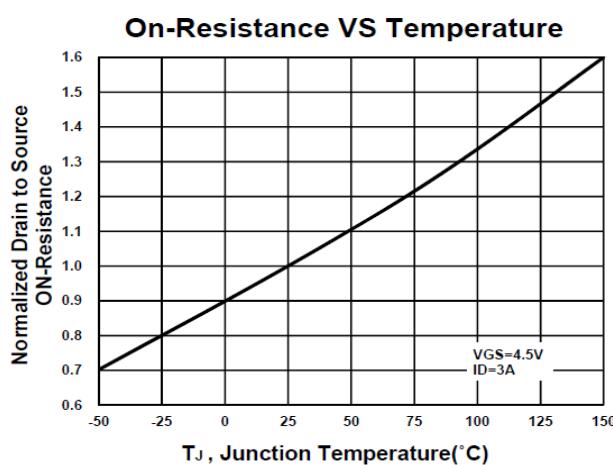
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Package Dimension

J-Lead MECHANICAL DATA

Dimension	mm			Dimension	Mm		
	Min.	Typ.	Max.		Min.	Typ.	Max.
A	2.95	3.05	3.3	H	0.3	0.45	0.6
B	2.3	2.4	2.5	J		7°	
C	2.65	2.85	3.05	K		0.04	
D	0.25	0.32	0.4	L	0.1	0.15	0.2
E		0.65		M	0°	4°	8°
F	0.92		1.0				
G	0.01		0.1				

